

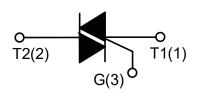
DESCRIPTION:

With high ability to withstand the shock loading of large current, T410-600B series triacs provide high dv/dt rate with strong resistance to electromagnetic interface. With high commutation performances, 3 quadrants products especially recommended for use on inductive load.



MAIN FEATURES

Symbol	Value	Unit
V _{DRM} /V _{RRM}	600/800	V
I _{T(RMS)}	4	A



ABSOLUTE MAXIMUM RATINGS

Pa	rameter	Symbol	Value	Unit
Storage junction temperature range		T _{stg}	-40 - 150	$^{\circ}\mathbb{C}$
Operating junction temperature range		Tj	-40 - 125	$^{\circ}$ C
Repetitive peak off-state voltage (T _j =25℃)		VDRM	600/800	V
Repetitive peak reverse voltage (T _j =25℃)		V _{RRM}	600/800	V
RMS on-state current	TO-252 (T _C =100°C)	I _{T(RMS)}	4	Α
Non repetitive surge peak on-state current (full cycle, F=50Hz)		I _{TSM}	40	А
I ² t value for fusing (tp=10ms)		l ² t	8	A ² s
Critical rate of rise of on-state current $(I_G = 2 \times I_{GT})$		dI/dt	50	A/µs
Peak gate current		l _{GM}	4	Α
Average gate power dissipation		P _{G(AV)}	1	W
Peak gate power		P _{GM}	5	W



ELECTRICAL CHARACTERISTICS (T_j =25 $^{\circ}$ C unless otherwise specified)

Symbol	Test Condition	Quadrant		Value			Unit	
	rest Condition			TW	sw	CW	BW	Uill
lgт	V _D =12V R _L =33Ω	I - II -III	MAX	5	10	35	50	mA
V _G T	VD-12V KL-3322	I - II -III	MAX	1.5				V
V _{GD}	$V_D = V_{DRM} T_j = 125^{\circ}C$ $R_L = 3.3 K\Omega$	I - II -III	MIN	0.2			V	
IL	I _G =1.2I _{GT}	I -III	MAX	10	20	50	70	mA
		II	IVIAA	15	35	60	80	IIIA
Ін	I _T =100mA		MAX	10	15	35	60	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	50	100	400	1000	V/µs

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
V _{TM}	I _{тм} =5.5A tp=380µs	T _j =25℃	1.5	V
IDRM	V _D =V _{DRM} V _R =V _{RRM}	T _j =25℃	10	μΑ
I _{RRM}		Tj=125℃	0.75	mA

THERMAL RESISTANCES

Symbol	Parameter		Value	Unit
R _{th(j-c)}	junction to case(AC)	TO-252	2.8	°C/W
R _{th(j-a)}	junction to ambient	10-252	70	C/VV



FIG.1: Maximum power dissipation versus RMS on-state current

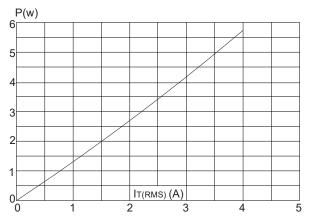


FIG.3: Surge peak on-state current versus number of cycles

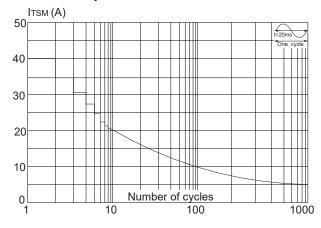


FIG.2: RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness:35µm)(full cycle)

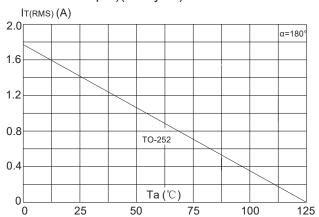


FIG.4: On-state characteristics (maximum values)

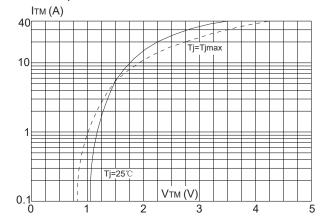




FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<20ms and corresponding value of I²t (dI/dt < 50A/µs)

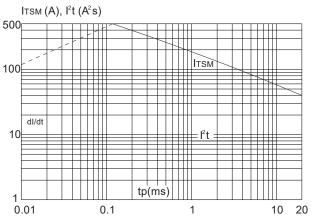
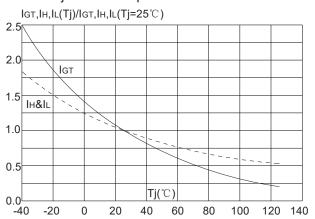


FIG.6: Relative variations of gate trigger current, holding current and latching current versus junction temperature



SOLDERING PARAMETERS

Reflow Condition		Pb-Free assembly		
		(see figure at right)		
	-Temperature Min	+150℃		
	(T _{s(min)})	+130 C		
Pre	-Temperature Max	+200℃		
Heat	(T _{s(max)})	+200 C		
	-Time (Min to Max)	60-180 secs.		
	(ts)	00-100 Secs.		
Average	ramp up rate	3°C/sec. Max		
(Liquidus Temp (T∟)to peak)		S C/Sec. Max		
T _{s(max)} to T _L - Ramp-up Rate		3℃/sec. Max		
	-Temperature(T _L)	+217℃		
Reflow	(Liquidus)	1217 0		
	-Temperature(t _L)	60-150 secs.		
Peak Temp (T _p)		+260(+0/-5)°C		
Time within 5℃of actual		20-40secs.		
Peak Temp (t _p)		20 .00000.		
Ramp-down Rate		6℃/sec. Max		
Time 25℃ to Peak Temp (T _P)		8 min. Max		
Do not exceed		+260℃		
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